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Application/Control No.	Applicant(s)/Patent under Reexamination
10/649,636	FUKUDA ET AL.
Examiner	Art Unit
Chelcie Daye	2161

SEARCHED				
Class	Subclass	Date	Examiner	
707	1,103X 205	4/28/2006	CLD	
711	12	4/28/2006	CLD	
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INTERFERENCE SEARCHED			
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SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
EAST (US-PGUB, USPAT, USOCR, EPO, JPO, IBM_TDB)	4/28/2006	CLD
Consulted with Sana Al-Hashemi	4/28/2006	CLD